

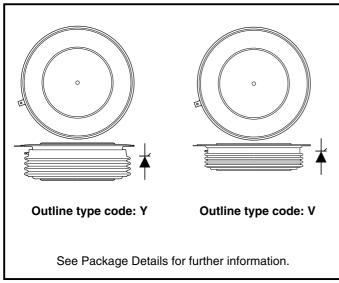
# **DCR1574SY / DCR1574SV**

# **Phase Control Thyristor**

Replaces July 2001 version, DS4400-4.0

DS4400-5.5 November 2002

## **PACKAGE OUTLINE**



# Fig. 1 Package outline

#### **KEY PARAMETERS**

 $\begin{array}{ll} \text{V}_{\text{DRM}} & 2800\text{V} \\ \text{I}_{\text{T(AV)}} & 3419\text{A} \\ \text{I}_{\text{TSM}} & 54500\text{A} \\ \text{dVdt} & 1000\text{V/}\mu\text{s} \\ \text{dI/dt} & 300\text{A/}\mu\text{s} \\ \end{array}$ 

## **VOLTAGE RATINGS**

Part Number	Repetitive Peak Voltages V <sub>DRM</sub> V <sub>RRM</sub>	Conditions
	v	
DCR1574SY28 or DCR1574SV28	2800 2800	$\begin{split} & T_{_{V_{j}}} = 0^{\circ} \text{ to } 125^{\circ}\text{C.} \\ & I_{_{DRM}} = I_{_{RRM}} = 300\text{mA.} \\ & V_{_{DRM}}, V_{_{RRM}} = 10\text{ms } 1/2 \text{ sine.} \\ & V_{_{DSM}} \& V_{_{RSM}} = V_{_{DRM}} \& V_{_{RRM}} + 100V \\ & \text{respectively.} \end{split}$

Lower voltage grades available.

#### **ORDERING INFORMATION**

When ordering select the required part number shown in the Voltage Ratings selection table.

For example:

DCR1574SY28 for a 2800V 'Y' outline variant

or

DCR1574SV28 for a 2800V 'V' outline variant

If a lower voltage grade is required, then use  $V_{\text{DRM}}/100$  for the grade required e.g.:

DCR1574SY26 for a 2600V 'Y' outline variant etc.

Note: Please use the complete part number when ordering and quote this number in any future correspondance relating to your order.



# **CURRENT RATINGS**

T<sub>case</sub> = 60°C unless stated otherwise

Symbol	Parameter	Conditions	Max.	Units			
Double Sid	Double Side Cooled						
I <sub>T(AV)</sub>	Mean on-state current	Half wave resistive load	3419	Α			
I <sub>T(RMS)</sub>	RMS value	-	5370	Α			
I <sub>T</sub>	Continuous (direct) on-state current	-	4836	Α			
Single Side Cooled (Anode side)							
I <sub>T(AV)</sub>	Mean on-state current	Half wave resistive load	2197	Α			
I <sub>T(RMS)</sub>	RMS value	-	3451	Α			
I <sub>T</sub>	Continuous (direct) on-state current	-	2857	Α			

## **CURRENT RATINGS**

 $T_{\text{case}} = 80^{\circ}\text{C}$  unless stated otherwise

Symbol	Parameter	Conditions	Max.	Units			
Double Sid	Double Side Cooled						
I <sub>T(AV)</sub>	Mean on-state current	Half wave resistive load	2667	Α			
I <sub>T(RMS)</sub>	RMS value	-	4189	Α			
I <sub>T</sub>	Continuous (direct) on-state current	-	3680	Α			
Single Side	Single Side Cooled (Anode side)						
I <sub>T(AV)</sub>	Mean on-state current	Half wave resistive load	1680	Α			
I <sub>T(RMS)</sub>	RMS value	-	2640	Α			
I <sub>T</sub>	Continuous (direct) on-state current	-	2140	Α			



# **SURGE RATINGS**

Symbol	Parameter	Conditions	Max.	Units
I <sub>TSM</sub>	Surge (non-repetitive) on-state current	10ms half sine; T <sub>case</sub> = 125°C	43.8	kA
l²t	I <sup>2</sup> t for fusing	V <sub>R</sub> = 50% V <sub>RRM</sub> - 1/4 sine	9.59 x 10 <sup>6</sup>	A²s
I <sub>TSM</sub>	Surge (non-repetitive) on-state current	10ms half sine; T <sub>case</sub> = 125°C	54.5	kA
l²t	I <sup>2</sup> t for fusing	V <sub>R</sub> = 0	14.85 x 10 <sup>6</sup>	A²s

# THERMAL AND MECHANICAL DATA

Symbol	Parameter	Conditions		Min.	Max.	Units
	Thermal resistance - junction to case	Double side cooled	dc	-	0.0095	°C/W
$R_{th(j-c)}$		Single side cooled	Anode dc	-	0.019	°C/W
			Cathode dc	-	0.019	°C/W
$R_{th(c-h)}$	Thermal resistance - case to heatsink	Clamping force 50kN with mounting compound	Double side	-	0.002	°C/W
			Single side	-	0.004	°C/W
$T_{v_{j}}$	Virtual junction temperature	On-state (conducting)		-	135	°C
		Reverse (blocking)		-	125	°C
T <sub>stg</sub>	Storage temperature range			-55	150	°C
-	Clamping force			45	55	kN



# **DYNAMIC CHARACTERISTICS**

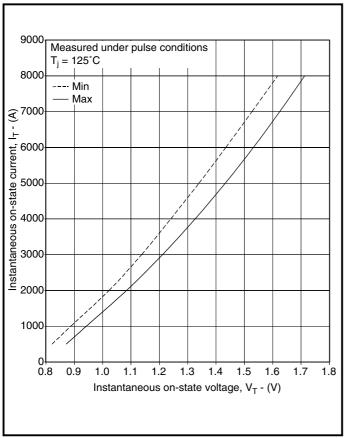
Symbol	Parameter	Conditions		Max.	Units
I <sub>RRM</sub> /I <sub>DRM</sub>	Peak reverse and off-state current	At V <sub>RRM</sub> /V <sub>DRM</sub> , T <sub>case</sub> = 125°C		300	mA
dV/dt	Maximum linear rate of rise of off-state voltage	To 67% $V_{DRM} T_j = 125^{\circ}C$ .		1000	V/μs
-11/-14	dl/dt Rate of rise of on-state current Gar	Gate source 20V, 10Ω	Repetitive 50Hz	250	A/μs
ai/at			Non-repetitive	500	A/μs
V <sub>T(TO)</sub>	Threshold voltage	At T <sub>vj</sub> = 125°C		0.883	٧
r <sub>T</sub>	On-state slope resistance	At T <sub>vj</sub> = 125°C		0.11	mΩ
t <sub>gd</sub>	Delay time	$V_{_{D}}$ = 67% $V_{_{DRM}}$ , Gate source 30V, 15 $\Omega$ , $t_{_{f}}$ ≤ 0.5 $\mu$ s, $T_{_{j}}$ = 25°C		2	μs
t <sub>q</sub>	Turn-off time	$\begin{aligned} & I_{_{T}} = 4000\text{A},  t_{_{p}} = 3\text{ms},  T_{_{j}} = 125^{\circ}\text{C}, \\ & V_{_{RM}} = 200\text{V},  dI_{_{RR}}\!/dt = 6\text{A}/\mu\text{s}, \\ & V_{_{DR}} = 67\%  V_{_{DRM}},  dV_{_{DR}}\!/dt = 20\text{V}/\mu\text{s}   \text{linear} \end{aligned}$		400	μs
I <sub>L</sub>	Latching current	$T_{j} = 25^{\circ}C, V_{D} = 5V$		1000	mA
I <sub>H</sub>	Holding current	$T_{j} = 25^{\circ}C, R_{g-k} = \infty$		300	mA

# **GATE TRIGGER CHARACTERISTICS AND RATINGS**

Symbol	Parameter	Conditions	Max.	Units
V <sub>GT</sub>	Gate trigger voltage	$V_{DRM} = 5V$ , $T_{case} = 25^{\circ}C$	3.0	V
I <sub>GT</sub>	Gate trigger current	$V_{DRM} = 5V$ , $T_{case} = 25^{\circ}C$	300	mA
$V_{\rm GD}$	Gate non-trigger voltage	At V <sub>DRM</sub> T <sub>case</sub> = 125°C	0.25	٧
V <sub>FGM</sub>	Peak forward gate voltage	Anode positive with respect to cathode	30	٧
$V_{FGN}$	Peak forward gate voltage	Anode negative with respect to cathode	0.25	٧
V <sub>RGM</sub>	Peak reverse gate voltage		5	٧
I <sub>FGM</sub>	Peak forward gate current	Anode positive with respect to cathode	30	Α
P <sub>GM</sub>	Peak gate power	See figs. 7 and 8, gate characteristics table	150	W
P <sub>G(AV)</sub>	Mean gate power		10	W



## **CURVES**





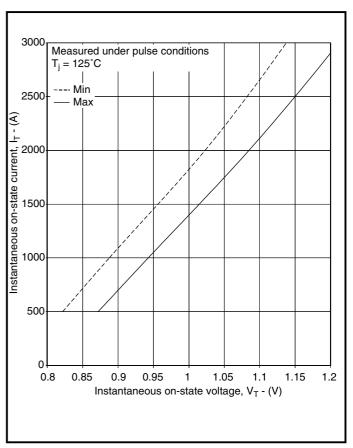


Fig.3 Maximum (limit) on-state characteristics

# $V_{TM}$ Equation:

$$V_{TM(max)} = A + BIn (I_T) + C.I_T + D. \sqrt{I_T}$$

Where A = 1.328994

B = -0.1381631  $C = 3.565973 \times 10^{-6}$  D = 0.01786171

These values are valid for  $T_i = 125^{\circ}C$  for  $I_T 500A$  to 6000A



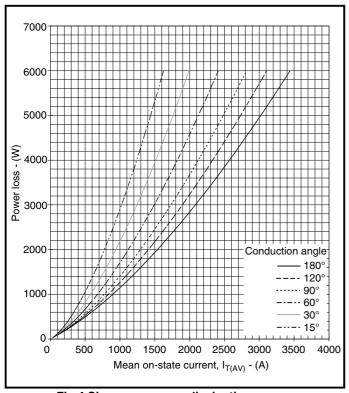


Fig.4 Sine wave power dissipation curves

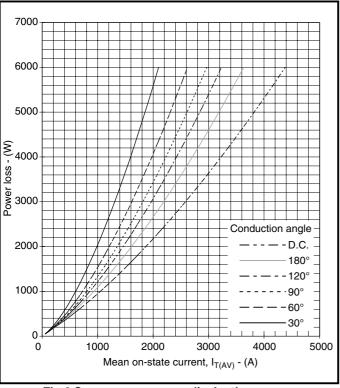


Fig.6 Square wave power dissipation curves

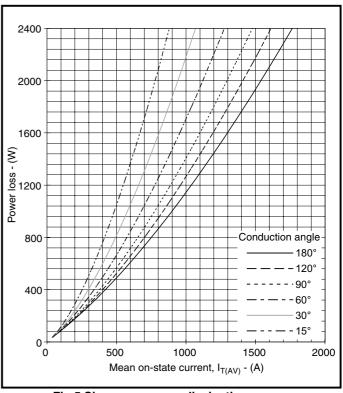


Fig.5 Sine wave power dissipation curves

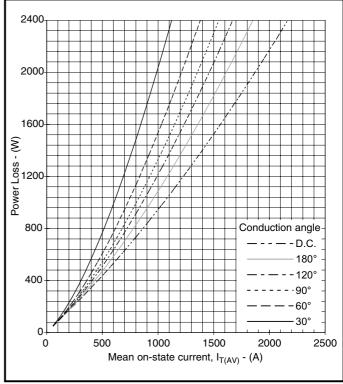


Fig.7 Square wave power dissipation curves



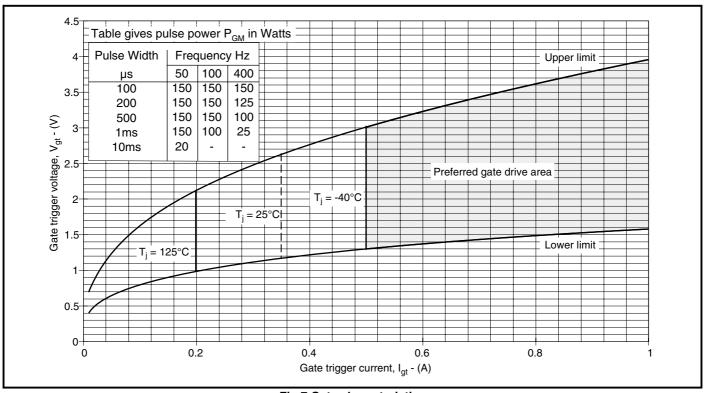


Fig.7 Gate characteristics

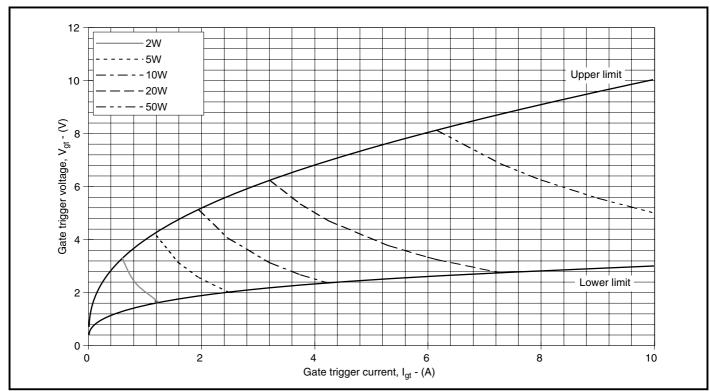
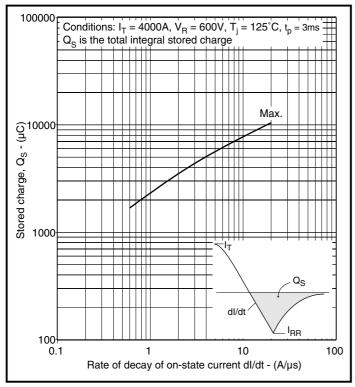


Fig.8 Gate characteristics





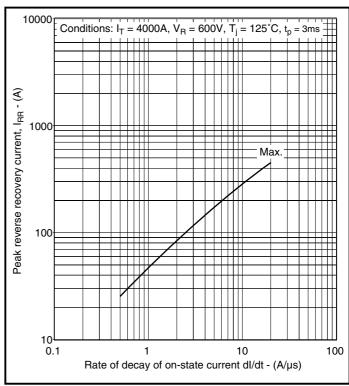


Fig.9 Stored charge

Fig.10 Reverse recovery current

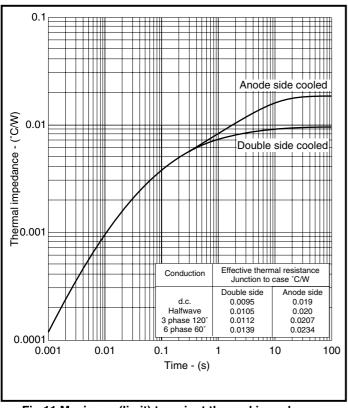


Fig.11 Maximum (limit) transient thermal impedance - junction to case

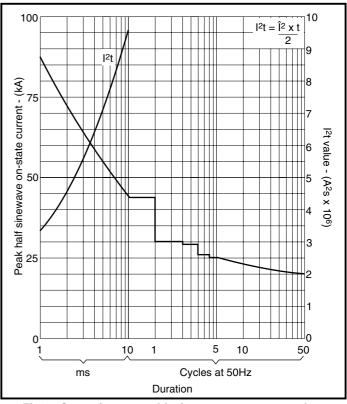


Fig.12 Surge (non-repetitive) on-state current vs time (with 50%  $V_{RRM}$  at  $T_{case}$  = 125°C)



## **PACKAGE DETAILS**

For further package information, please contact Customer Service. All dimensions in mm, unless stated otherwise. DO NOT SCALE.

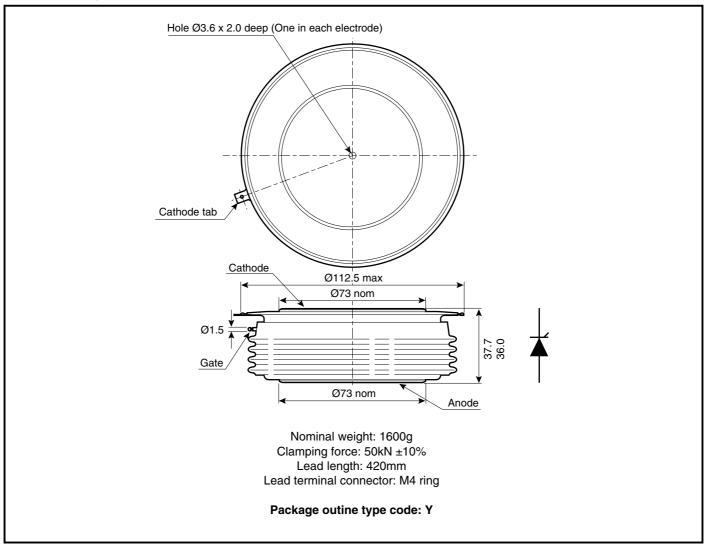


Fig.12 Package details



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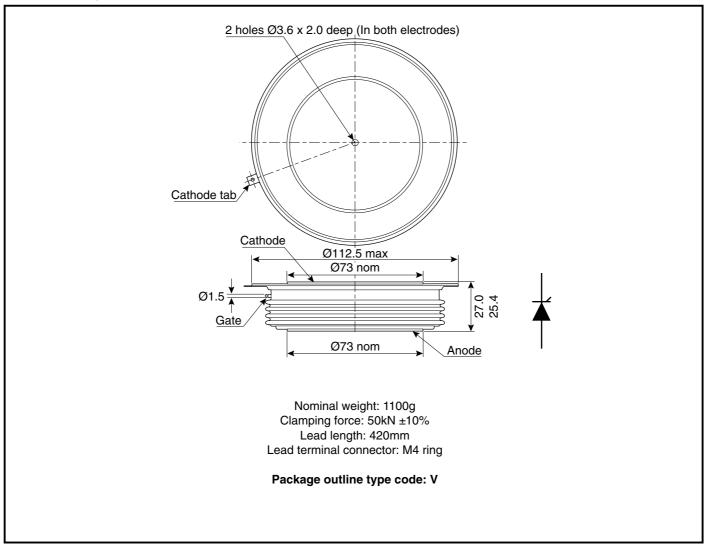


Fig.12 Package details



#### **POWER ASSEMBLY CAPABILITY**

The Power Assembly group was set up to provide a support service for those customers requiring more than the basic semiconductor, and has developed a flexible range of heatsink and clamping systems in line with advances in device voltages and current capability of our semiconductors.

We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group offers high quality engineering support dedicated to designing new units to satisfy the growing needs of

Using the latest CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete Solution (PACs).

#### **HEATSINKS**

The Power Assembly group has its own proprietary range of extruded aluminium heatsinks which have been designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or Customer Services.

Stresses above those listed in this data sheet may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed.



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